

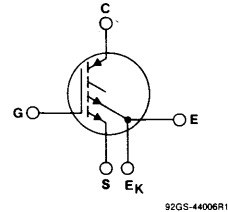
Current Sensing IGT™ Transistors Insulated Gate Bipolar Transistors

10 A, 500 V
 $r_{DS(on)} = 0.27 \Omega$

Features:

- Low $V_{CE(sat)}$ - 2.5 V typ. @ 10 A
- Ultra-fast turn-on - 100 ns typical
- Polysilicon MOS gate - voltage controlled turn on/off
- High current handling - 10 A @ 100° C case
- Current sensing pilot

TERMINAL DIAGRAM

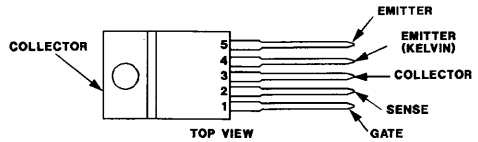


The GS1510 and/or IGT5E10CS Series IGT™ Transistor (Insulated Gate Bipolar Transistor) is a MOS-gate turn on/off power switching device combining the best advantages of power MOSFETs, bipolar transistors, and current sensing pilots. The result is a device that has the high input impedance of MOSFETs and the low on-state conduction losses similar to bipolar transistors. The device design and gate characteristics of the IGT™ Transistor are also similar to power MOSFETs. An important difference is the equivalent $r_{ds(on)}$ drain resistance which is modulated to a low value (10 times lower) when the gate is turned on. The much lower on-state voltage drop also varies only moderately between 25° C and 150° C offering extended power handling capability.

The IGT™ Transistor is ideal for many high-voltage switching applications operating at low frequencies and where low conduction losses are essential, such as AC and DC motor controls, power supplies and drivers for solenoids, relays, and contactors.

N-CHANNEL ENHANCEMENT MODE

TERMINAL DESIGNATION



TO-220 (5 LEAD)

MAXIMUM RATINGS

COLLECTOR-EMITTER VOLTAGE ($V_{GE} = 0 V$)	V_{CES}	500	V
COLLECTOR-GATE VOLTAGE ($R_{GE} = 1 M\Omega$)	V_{CGR}	500	V
CONTINUOUS DRAIN CURRENT	I_C		
At $T_c = 100^\circ C$		10	A
At $T_c = 25^\circ C$		18	A
PULSED COLLECTOR CURRENT	I_{CM}^*	40	A
GATE-EMITTER VOLTAGE	V_{GE}	± 25	V
TOTAL POWER DISSIPATION	P_D		
At $T_c = 25^\circ C$		75	W
Derate Above 25° C		0.6	W/°C
OPERATING AND STORAGE JUNCTION TEMPERATURE RANGE	T_J, T_{stg}	-55 to +150	°C
THERMAL RESISTANCE, JUNCTION-TO-CASE	$R_{\theta JC}$	1.67	°C/W
MAXIMUM LEAD TEMPERATURE FOR SOLDERING PURPOSES	T_L		
1/8 inch from case for 5 seconds		260	°C

*Repetitive Rating: Pulse width limited by maximum junction temperature.
Gate control turn-off not allowed above 50 amperes.

Harris Semiconductor IGBT product is covered by one or more of the following U.S. patents:

4,364,073	4,417,385	4,430,792	4,443,931	4,466,176	4,532,534	4,567,641
4,587,713	4,618,872	4,620,211	4,631,564	4,639,754	4,639,762	4,641,162
4,644,637	4,682,195	4,684,413	4,717,679	4,794,432	4,801,986	4,803,533
4,809,045	4,810,665					

ELECTRICAL CHARACTERISTICS $T_C = 25^\circ\text{C}$ Unless Otherwise Specified

CHARACTERISTIC	TEST CONDITIONS	LIMITS			UNITS
		MIN.	TYP.	MAX.	

OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage	BV_{CES}	$V_{GE} = 0\text{ V}, I_C = 25\ \mu\text{A}$	500	—	—	V
Collector Cut-off Current	I_{CES}	$V_{CE} = \text{Max. Rating}$ $V_{GE} = 0\text{ V}, T_C = 25^\circ\text{C}$	—	—	250	μA
		$V_{CE} = \text{Max. Rating} \times 0.8$ $V_{GE} = 0\text{ V}, T_C = 150^\circ\text{C}^{(1)}$	—	—	4	mA
Gate-Emitter Leakage Current	I_{GES}	$V_{GE} = \pm 20\text{ V}$	—	—	± 500	nA

ON CHARACTERISTICS⁽²⁾

Gate Threshold Voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}, I_C = 250\ \mu\text{A}$ $T_C = 25^\circ\text{C}$ $T_C = 150^\circ\text{C}$	2 —	4 2.5	5 —	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{GE} = 15\text{ V}, I_C = 10\text{ A}, T_C = 25^\circ\text{C}$	—	2.5	2.7	
		$V_{GE} = 15\text{ V}, I_C = 10\text{ A}, T_C = 150^\circ\text{C}$	—	2.8	—	
		$V_{GE} = 10\text{ V}, I_C = 10\text{ A}, T_C = 25^\circ\text{C}$	—	2.9	—	

DYNAMIC CHARACTERISTICS

Input Capacitance	C_{ies}	$V_{GE} = 0\text{ V}$	—	1050	—	pF
Output Capacitance	C_{oes}	$V_{CE} = 25\text{ V}$	—	340	—	
Reverse Transfer Capacitance	C_{res}	$f = 1\text{ MHz}$	—	10	—	

SWITCHING CHARACTERISTICS⁽²⁾ (See Figs. 8 & 9)

Turn-On Delay Time	$t_{d(on)}$	Resistive Load, $T_J = 125^\circ\text{C}$ $I_C = 10\text{ A}, V_{CE} = 400\text{ V}$ $V_{GE} = 15\text{ V}$ $R_{G(on)} = 50\ \Omega, R_{G(off)} = 100\ \Omega$	—	100	—	ns
Rise Time	t_r		—	100	—	
Turn-Off Delay Time	$t_{d(off)}$		—	0.4	—	
Fall Time	t_f	Inductive Load, $T_J = 125^\circ\text{C}$ $L = 45\ \mu\text{H}, I_C = 10\text{ A}$ $V_{CE(clamp)} = 400\text{ V}, V_{GE} = 15\text{ V}$ $R_{G(on)} = 50\ \Omega, R_{G(off)} = 100\ \Omega$	—	2.5	—	μs
Turn-Off Delay Time	$t_{d(off)}$		—	0.8	1.2	
Fall Time	t_f		—	0.8	1.0	
Equivalent Fall Time	$t_{f(eq)}$		—	0.6	0.8	
Turn-Off Switching Losses	E_f		—	1.6	2.0	

PILOT CHARACTERISTICS^{(2) (3) (4)}

Pilot - Emitter Kelvin Voltage	V_{PEK}	$V_{GE} = 15\text{ Vdc}, R_P = 2\text{ K}\Omega$	—	1.25	—	V
$I_C = 5\text{ A}$			1.4	1.67	1.8	
$I_C = 10\text{ A}$			—	2.06	—	
$I_C = 20\text{ A}$			—	—	—	

⁽¹⁾ Applies for 3.3°C per watt maximum thermal resistance, case-to-ambient.⁽²⁾ Pulse test: Pulse widths $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.⁽³⁾ Refer to Fig. 10.⁽⁴⁾ When Not in Use Connect E_P to Emitter.

GSI510, IGT5E10CS

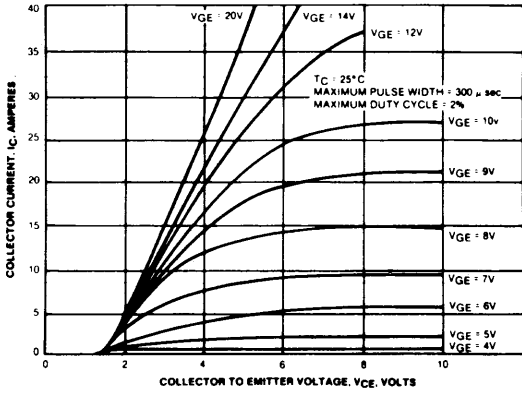


Fig. 1 - Typical output characteristics.

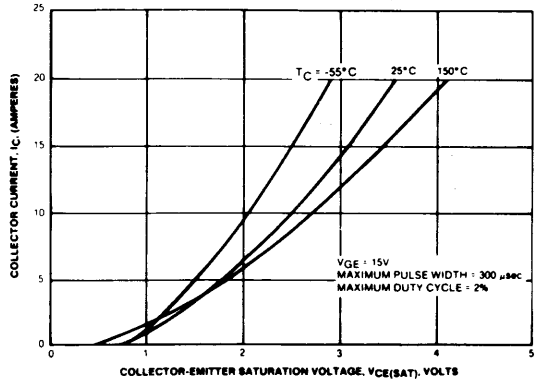


Fig. 2 - Typical collector-emitter saturation voltage.

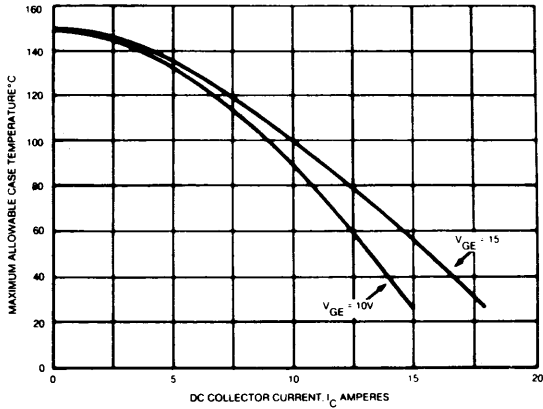


Fig. 3 - Maximum allowable case temperature vs. DC collector current.

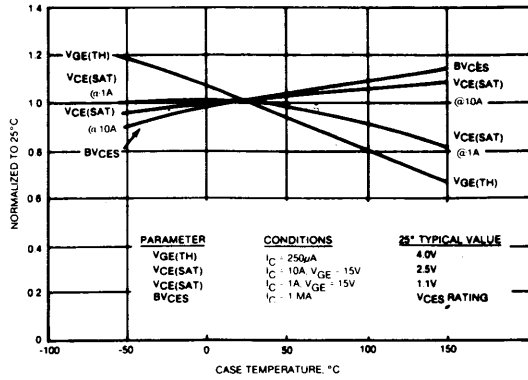


Fig. 4 - Typical temperature dependence of parameters.

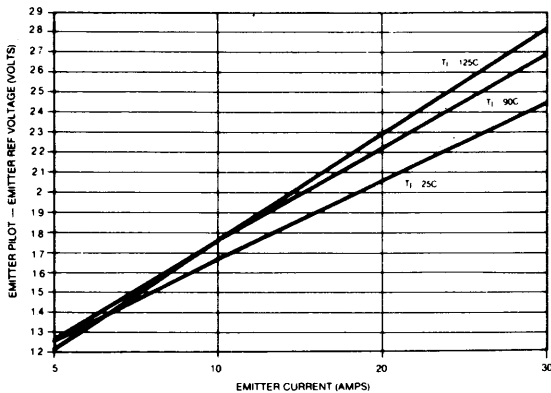


Fig. 5A - Typical emitter pilot characteristics 2 Kohm pilot resistor.

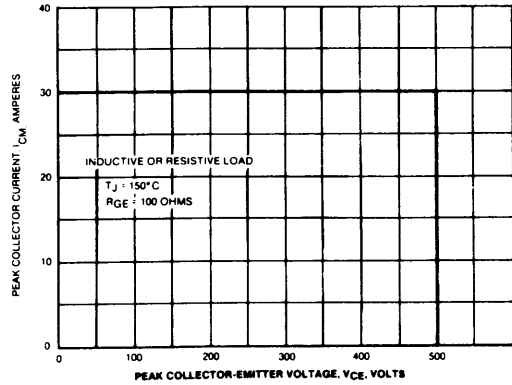


Fig. 5B - Turn-off safe operating area.

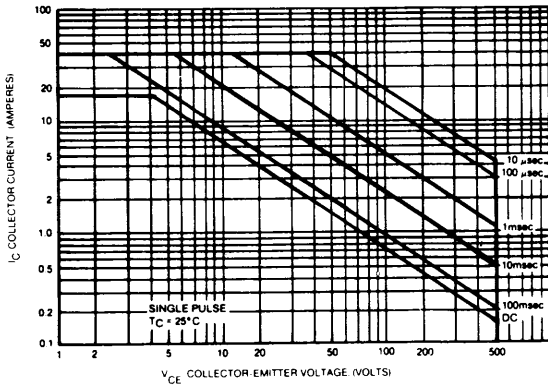


Fig. 6 - Turn-on safe operating area.

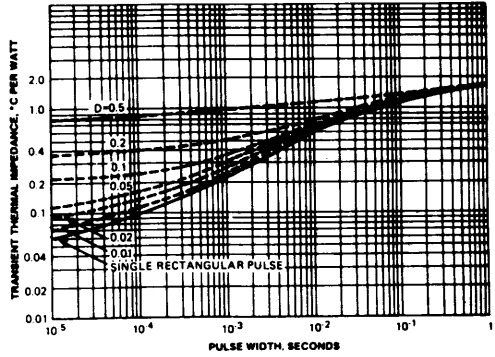


Fig. 7 - Maximum transient thermal impedance.

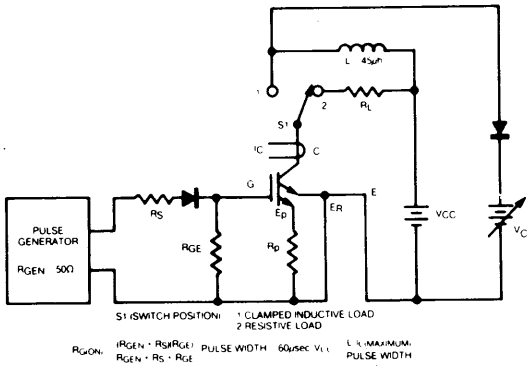


Fig. 8 - Basic switching test circuit.

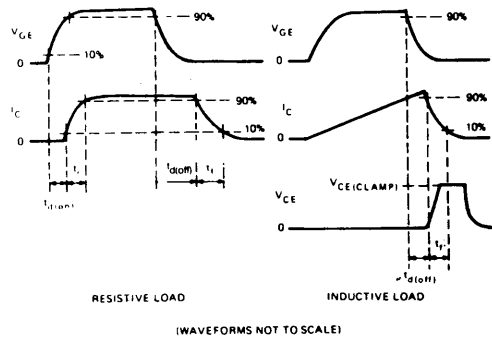


Fig. 9 - Switching waveforms.

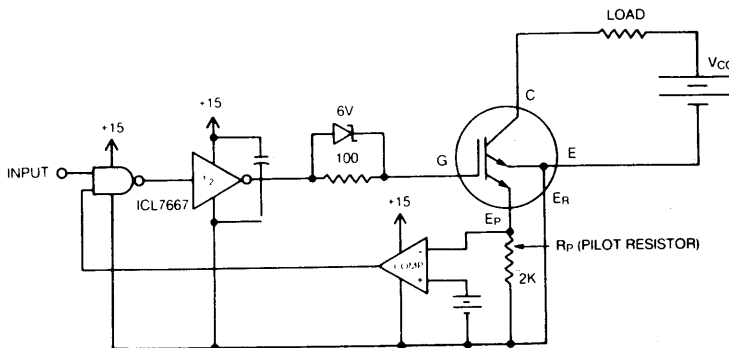


Fig. 10 - Typical circuit utilizing the emitter pilot for overcurrent protection.

Current Sensing IGT™ Transistors

Insulated Gate Bipolar Transistors

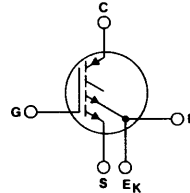
25 A, 500 V

$r_{DS(on)} = 0.105 \Omega$

Features:

- Low $V_{CE(sat)}$ - 1.8 V typ. @ 25 A
- Ultra-fast turn-on - 150 ns typical
- Polysilicon MOS gate - voltage controlled turn on/off
- High current handling - 25 A @ 85°C case
- Current sensing pilot

TERMINAL DIAGRAM



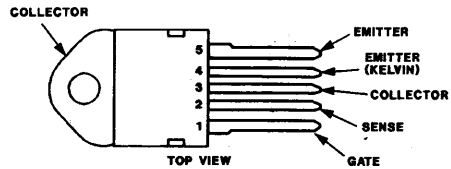
92GS-4406R1

N-CHANNEL ENHANCEMENT MODE

The GSI525 and/or IGT7E20CS IGT™ Transistor (Insulated-Gate Bipolar Transistor) is a MOS-Gated power-switching device combining the best features of power MOSFETs and bipolar transistors with current sensing pilots. The result is a device that has the high input impedance of MOSFETs and the low on-state conduction losses of bipolar transistors. The gate characteristics of the IGT™ Transistor are similar to power MOSFETs but its equivalent $r_{DS(on)}$ drain resistance is ten times lower and varies only moderately between 25°C and 150°C, thus offering extended power handling capability.

The IGT™ Transistor is ideal for many high voltage switching applications up to 5 kHz where low conduction losses are essential; ac and dc motor controls, power supplies and drivers for solenoids, relays, and contactors.

TERMINAL DESIGNATION



TO-218 (5 LEAD)

MAXIMUM RATINGS

COLLECTOR-EMITTER VOLTAGE ($V_{GE} = 0$ V)	V_{CES}	_____ 500 _____	V
COLLECTOR-GATE VOLTAGE ($R_{GE} = 1$ M Ω)	V_{CGR}	_____ 500 _____	V
CONTINUOUS DRAIN CURRENT	I_C	_____ 25 _____	A
At $T_C = 85^\circ\text{C}$		_____ 80 _____	A
PULSED COLLECTOR CURRENT	I_{CM}^*	_____ ± 20 _____	V
GATE-EMITTER VOLTAGE	V_{GE}	_____ 125 _____	W
TOTAL POWER DISSIPATION	P_D	_____ 1 _____	W/ $^\circ\text{C}$
At $T_C = 25^\circ\text{C}$		_____ -40 to +150 _____	$^\circ\text{C}$
Derate Above 25°C		_____ 1 _____	$^\circ\text{C}/\text{W}$
OPERATING AND STORAGE JUNCTION TEMPERATURE RANGE	T_J, T_{stg}	_____ 1 _____	$^\circ\text{C}/\text{W}$
THERMAL RESISTANCE, JUNCTION TO CASE	$R_{\theta JC}$	_____ 260 _____	$^\circ\text{C}$
MAXIMUM LEAD TEMPERATURE FOR SOLDERING PURPOSES	T_L		
1/8 inch from case for 5 seconds			

*Repetitive Rating: Pulse width limited by maximum junction temperature.
Gate control turn-off not allowed above 50 amperes.

Harris Semiconductor IGBT product is covered by one or more of the following U.S. patents:

- | | | | | | | |
|-----------|-----------|-----------|-----------|-----------|-----------|-----------|
| 4,364,073 | 4,417,385 | 4,430,792 | 4,443,931 | 4,466,176 | 4,532,534 | 4,567,641 |
| 4,587,713 | 4,618,872 | 4,620,211 | 4,631,564 | 4,639,754 | 4,639,762 | 4,641,162 |
| 4,644,637 | 4,682,195 | 4,684,413 | 4,717,679 | 4,794,432 | 4,801,986 | 4,803,533 |
| 4,809,045 | 4,810,665 | | | | | |

ELECTRICAL CHARACTERISTICS, $T_c = 25^\circ\text{C}$ Unless Otherwise Specified

CHARACTERISTIC	TEST CONDITIONS	LIMITS			UNITS
		MIN.	TYP.	MAX.	

OFF CHARACTERISTICS

Collector-Emitter Breakdown Voltage	BV_{CES}	$V_{GE} = 0\text{ V}, I_c = 250\ \mu\text{A}$	500	—	—	V
Collector Cut-off Current	I_{CES}	$V_{CE} = \text{Max. Rating}$ $V_{GE} = 0\text{ V}, T_c = 25^\circ\text{C}$	—	—	250	μA
		$V_{CE} = \text{Max. Rating} \times 0.8$ $V_{GE} = 0\text{ V}, T_c = 125^\circ\text{C}(1)$	—	—	4	mA
Gate-Emitter Leakage Current	I_{GES}	$V_{GE} = \pm 20\text{ V}$	—	—	± 500	nA

ON CHARACTERISTICS(2)

Gate Threshold Voltage	$V_{GE(th)}$	$V_{CE} = V_{GE}, I_c = 500\ \mu\text{A}$ $T_c = 25^\circ\text{C}$ $T_c = 150^\circ\text{C}$	2 —	4 2	5.5 —	V
Collector-Emitter Saturation Voltage	$V_{CE(sat)}$	$V_{GE} = 15\text{ V}, I_c = 25\text{ A}$ $T_c = 25^\circ\text{C}$ $T_c = 150^\circ\text{C}$	— —	1.8 1.9	2.6 —	

DYNAMIC CHARACTERISTICS

Input Capacitance	C_{ies}	$V_{GE} = 0\text{ V}$	—	2300	—	pF
Output Capacitance	C_{oes}	$V_{CE} = 25\text{ V}$	—	250	—	
Reverse Transfer Capacitance	C_{res}	$f = 1\text{ MHz}$	—	35	—	

SWITCHING CHARACTERISTICS(2) (See Figs. 8 & 9)

Turn-on Delay Time	$t_d(on)$	Resistive Load, $T_J = 150^\circ\text{C}$ $I_c = 25\text{ A}, V_{CE} = 400\text{ V}$ $V_{GE} = 15\text{ V}$ $R_{\theta(on)} = 50\ \Omega, R_{\theta(off)} = 50\ \Omega$	—	100	—	ns
Rise Time	t_r		—	150	—	
Turn-off Delay Time	$t_d(off)$		—	0.6	—	
Fall Time	t_f	Inductive Load, $T_J = 150^\circ\text{C}$ $L = 45\ \mu\text{H}, I_c = 25\text{ A}$ $V_{CE(clamp)} = 400\text{ V}, V_{GE} = 15\text{ V}$ $R_{\theta(on)} = 50\ \Omega, R_{\theta(off)} = 50\ \Omega$	—	1.5	2.5	μs
Turn-off Delay Time	$t_d(off)$		—	1.2	1.6	
Fall Time	t_f		—	5	8	
Turn-off Switching Losses	E_r		—	5	8	mJ

PILOT CHARACTERISTICS(2)(3)(4)

Pilot - Emitter Kelvin Voltage	V_{PEK}	$V_{GE} = 15\text{ Vdc}, R_P = 1\text{ K}\Omega$	1	1.3	1.6	V
$I_c = 20\text{ A}$			—	1.45	—	
$I_c = 30\text{ A}$			—	1.7	—	

(1) Applies for 3.3°C per watt maximum thermal resistance, case to ambient.(2) Pulse test: Pulse widths $\leq 300\ \mu\text{s}$, duty cycle $\leq 2\%$.

(3) Refer to Fig. 5(a).

(4) When not in use connect P to Emitter.

GSI525, IGT7E20CS

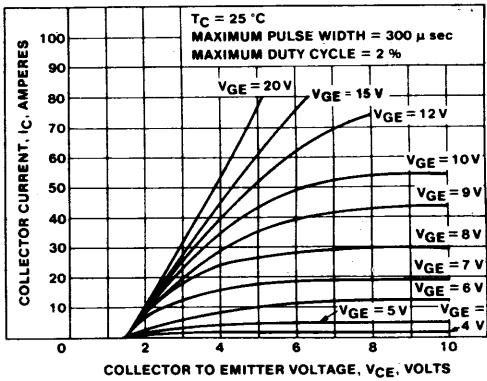


Fig. 1 - Typical output characteristics.

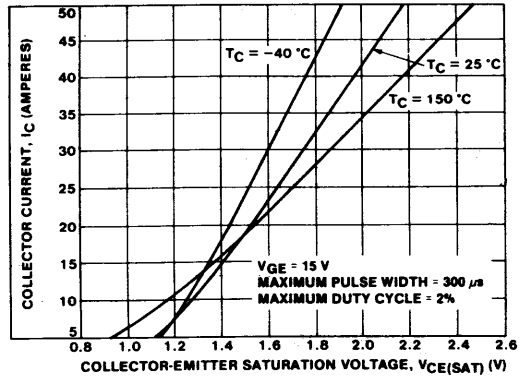


Fig. 2 - Typical collector-emitter saturation voltage

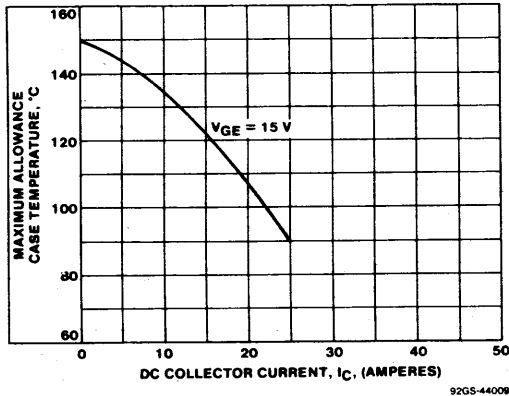


Fig. 3 - Maximum allowable dc collector current vs. case temperature.

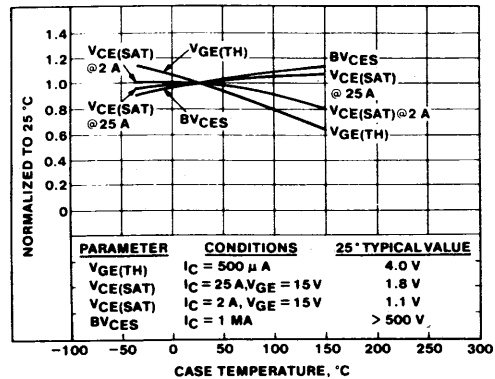


Fig. 4 - Typical temperature dependence of parameters.

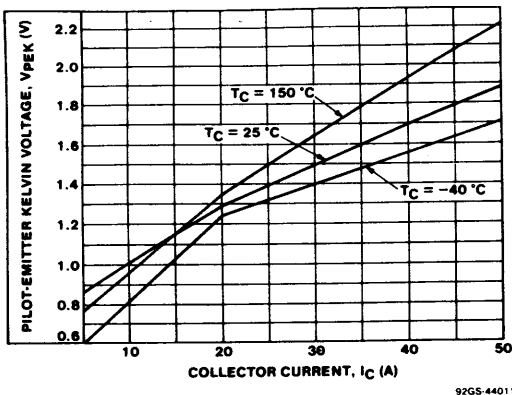


Fig. 5(a) - Typical emitter pilot characteristics - 1 KΩ pilot resistor.

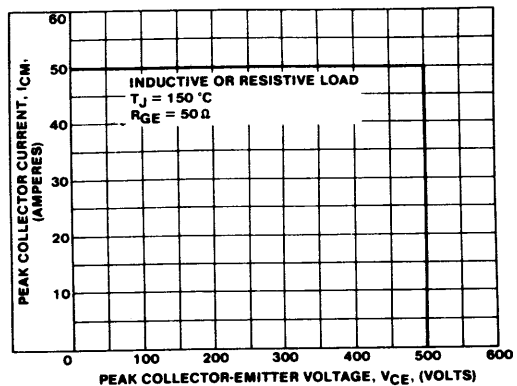


Fig. 5(b) - Turn-off safe operating area.